

Thermal Analysis for Materials Innovation

Thermal Analysis Forum Delaware Valley (TAFDV)
Fall Symposium - Tuesday, September 29, 2015

~ at ~

The National Institute of Standards and Technology (NIST)
100 Bureau Drive, Gaithersburg, MD 20899

CALL FOR PRESENTATIONS AND POSTERS

Please submit: authors, affiliation, title and brief abstract by **August 14, 2015**
Indicate preference for poster/oral presentation.

Invited Talks:

“Opportunities for Thermal Analysis in Metals-Based Additive Manufacturing”
Brandon M. Lane, NIST

“Measurement Protocols and Standard Reference Materials for Thermoelectric Energy
Conversion” Joshua Martin, NIST

“Qualifying and Quantifying Order in Semiconducting Polymers” Chad Snyder, NIST

“Advances in Nanocalorimetry” Feng Yi, NIST

REGISTRATION LINK: https://www-s.nist.gov/CRS/conf_disclosure.cfm?&conf_id=8573

Participant registration is FREE
(QR code is also the registration link)



All visitors must register at least 7
days in advance with the NIST
visitor registration system.

Lunch is available for purchase.

Abstract Submission and Inquires:

david.lavan@nist.gov

David LaVan
TAFDV Fall 2015 Symposium Chair
NIST
100 Bureau Drive, MS 8520
Gaithersburg MD 20899-8520

For vendor registration for the Instrument
Exhibition, please contact and send
appropriate fee to:

GSlough@tainstruments.com

Gray Slough
TAFDV Treasurer
TA Instruments-Waters LLC
159 Lukens Drive
New Castle DE 19720

**ASTM E37 Meeting will follow at
NIST on Wednesday, Sept. 30th**

**UL 746b Meeting will precede at
NIST on Monday, Sept. 28th**